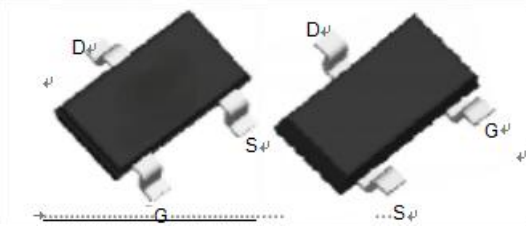
AO3400A

30V N-Channel MOSFET

General Description

The AO3400A combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. This device is suitable for use as a load switch or in PWM applications.

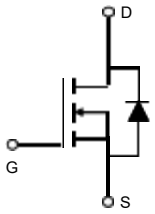


Product Summary

V_{DS}	30V
I_D (at V_{GS}=10V)	5.7A
$R_{DS(ON)}$ (at V_{GS}=10V)	< 26.5mΩ
$R_{DS(ON)}$ (at V_{GS} = 4.5V)	< 32mΩ
$R_{DS(ON)}$ (at V_{GS} = 2.5V)	< 48mΩ

SOT23

Top View **Bottom View**



Absolute Maximum Ratings T_A=25°C unless otherwise noted

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V_{DS}	30	V
Gate-Source Voltage		V_{GS}	±12	V
Continuous Drain Current	T_A=25°C	I_D	5.7	A
	T_A=70°C		4.7	
Pulsed Drain Current [C]		I_{DM}	30	
Power Dissipation [B]	T_A=25°C	P_D	1.4	W
	T_A=70°C		0.9	
Junction and Storage Temperature Range		T_J, T_{STG}	-55 to 150	°C

Thermal Characteristics

Parameter		Symbol	Typ	Max	Units
Maximum Junction-to-Ambient [A]	t ≤ 10s	$R_{\theta JA}$	70	90	°C/W
Maximum Junction-to-Ambient [A D]	Steady-State		100	125	°C/W
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	63	80	°C/W

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Typ	Max	Units
STATIC PARAMETERS							
BV_{DSS}	Drain-Source Breakdown Voltage	I_D=250μA, V_{GS}=0V		30			V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS}=30V, V_{GS}=0V				1	μA
			T_J=55°C			5	
I_{GSS}	Gate-Body leakage current	V_{DS}=0V, V_{GS}= ±12V				100	nA
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS} I_D=250μA		0.65	1.05	1.45	V
$I_{D(ON)}$	On state drain current	V_{GS}=4.5V, V_{DS}=5V		30			A
$R_{DS(ON)}$	Static Drain-Source On-Resistance	V_{GS}=10V, I_D=5.7A			18	26.5	mΩ
			T_J=125°C		28	38	
		V_{GS}=4.5V, I_D=5A			19	32	mΩ
		V_{GS}=2.5V, I_D=3A			24	48	mΩ
g_{FS}	Forward Transconductance	V_{DS}=5V, I_D=5.7A			33		S
V_{SD}	Diode Forward Voltage	I_S=1A,V_{GS}=0V			0.7	1	V
I_S	Maximum Body-Diode Continuous Current					2	A
DYNAMIC PARAMETERS							
C_{iss}	Input Capacitance	V_{GS}=0V, V_{DS}=15V, f=1MHz			630		pF
C_{oss}	Output Capacitance				75		pF
C_{rss}	Reverse Transfer Capacitance				50		pF
R_g	Gate resistance	V_{GS}=0V, V_{DS}=0V, f=1MHz		1.5	3	4.5	Ω
SWITCHING PARAMETERS							
Q_g	Total Gate Charge	V_{GS}=4.5V, V_{DS}=15V, I_D=5.7A			6	7	nC
Q_{gs}	Gate Source Charge				1.3		nC
Q_{gd}	Gate Drain Charge				1.8		nC
$t_{D(on)}$	Turn-On DelayTime	V_{GS}=10V, V_{DS}=15V, R_L=2.6Ω, R_{GEN}=3Ω			3		ns
t_r	Turn-On Rise Time				2.5		ns
$t_{D(off)}$	Turn-Off DelayTime				25		ns
t_f	Turn-Off Fall Time				4		ns
t_{rr}	Body Diode Reverse Recovery Time	I_F=5.7A, dI/dt=100A/μs			8.5		ns
Q_{rr}	Body Diode Reverse Recovery Charge	I_F=5.7A, dI/dt=100A/μs			2.6		nC

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25 ° C. The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on $T_{J(MAX)}$=150 ° C, using ≤ 10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$=150 ° C. Ratings are based on low frequency and duty cycles to keep initialT_J=25 ° C.

D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of $T_{J(MAX)}$=150 ° C. The SOA curve provides a single pulse rating.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

AO3400A

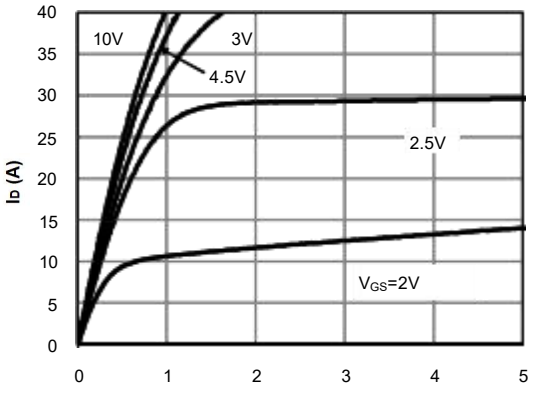


Fig 1: On-Region Characteristics (Note E)

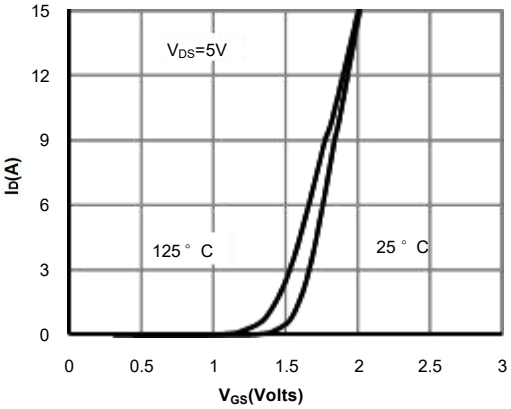


Figure 2: Transfer Characteristics (Note E)

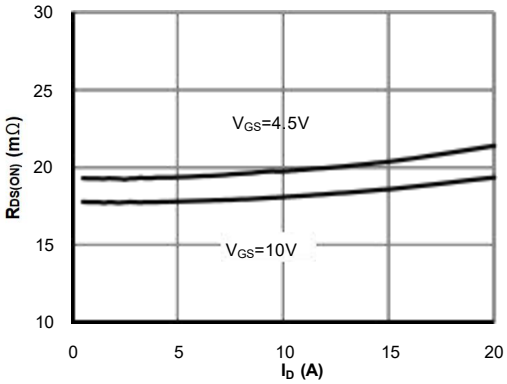


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

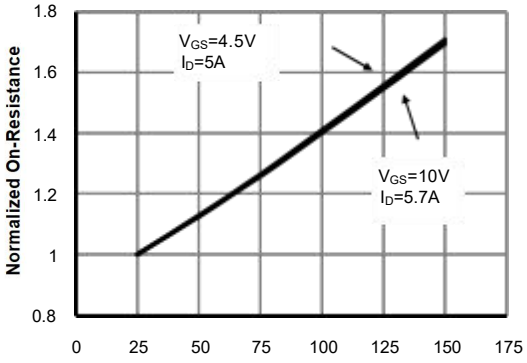


Figure 4: On-Resistance vs. Junction Temperature (Note E)

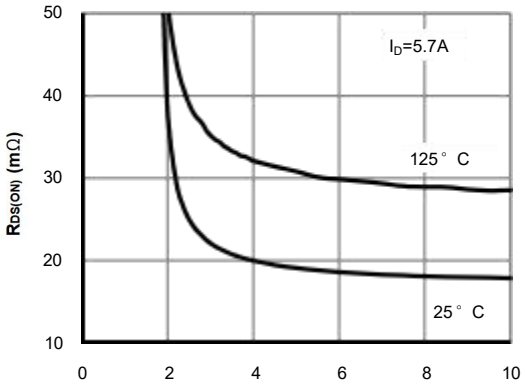


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

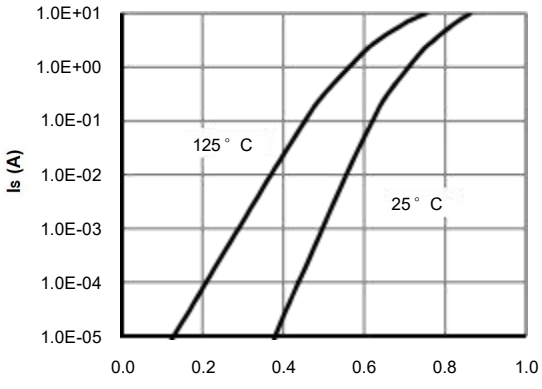


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

AO3400A

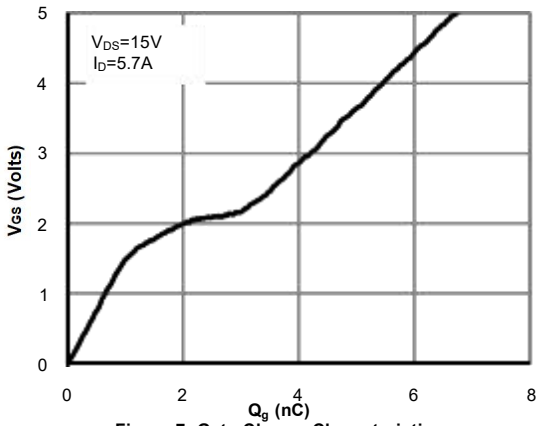


Figure 7: Gate-Charge Characteristics

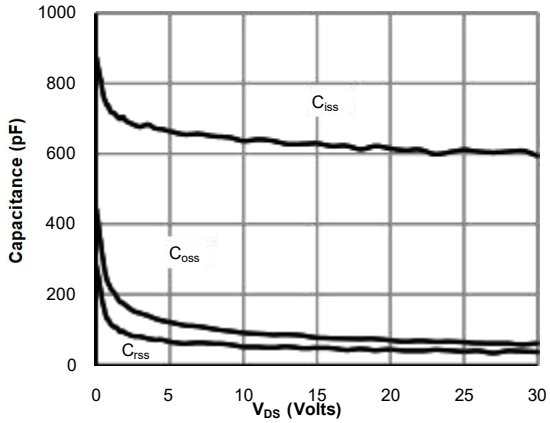


Figure 8: Capacitance Characteristics

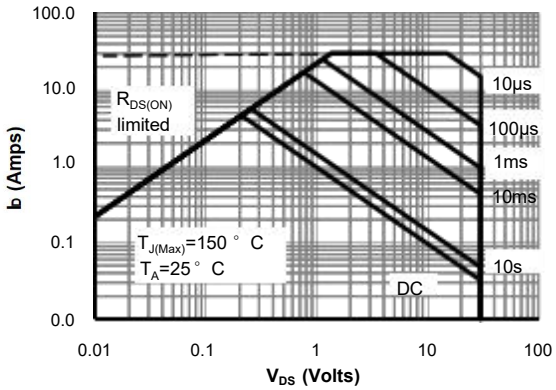


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

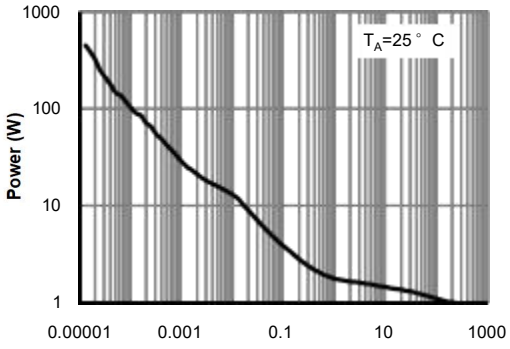


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)

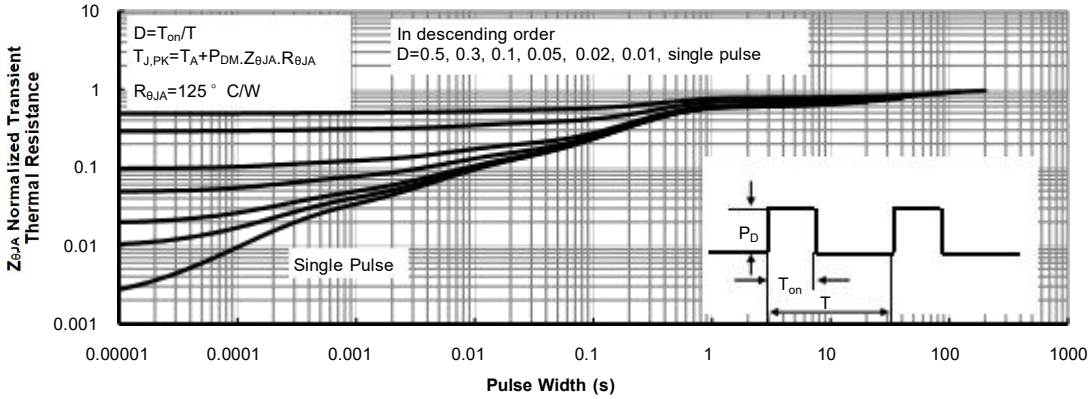
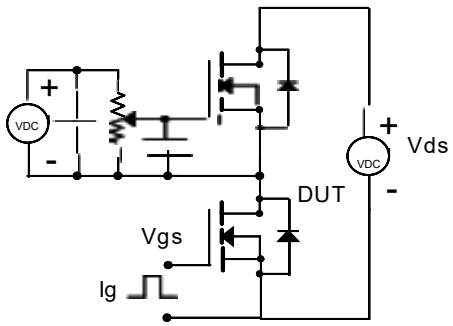
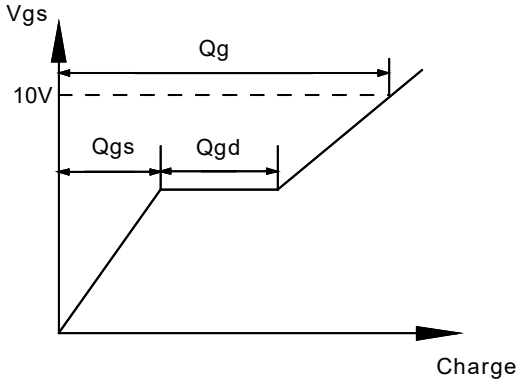


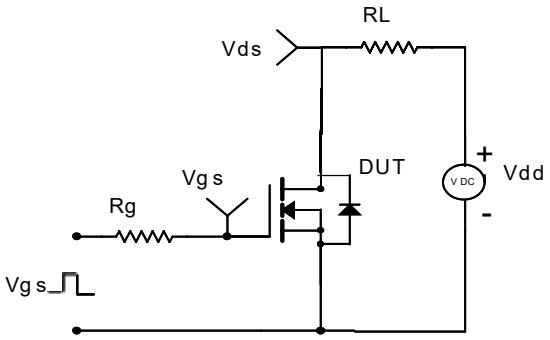
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

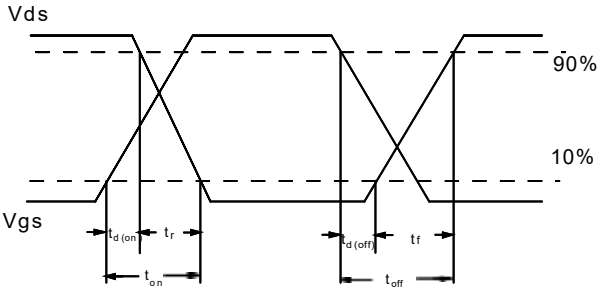
Gate Charge Test Circuit & Waveform





Resistive Switching Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms